

Notice of References Cited

Application/Control No.

10/821,215

Applicant(s)/Patent Under
Reexamination
WANG ET AL.

Examiner

BRIAN P. YENKE

Art Unit

2622

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,774,857	06-1998	Newlin, Douglas J.	704/271
*	B	US-6,754,905	06-2004	Gordon et al.	725/38
*	C	US-6,041,343	03-2000	Nguyen et al.	709/203
*	D	US-6,906,741	06-2005	Canova et al.	348/14.08
*	E	US-6,501,751	12-2002	Leviton et al.	370/352
*	F	US-2004/0244056	12-2004	Lorenz et al.	725/135
*	G	US-6,904,610	06-2005	Bayrakeri et al.	725/54
*	H	US-5,543,851	08-1996	Chang, Wen F.	348/468
*	I	US-5,936,661	08-1999	Trew, Timothy I. P.	725/114
*	J	US-5,781,245	07-1998	Van Der Weij et al.	725/105
*	K	US-2002/0129381	09-2002	Barone et al.	725/137
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	X					

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